

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

pplication of

Kazuhide URIU et al.

Mail Stop: PCT

Serial No. 10/552,759

Attorney Docket No. 2005 1579A

Filed October 11, 2005

METHOD AND APPARATUS FOR ANALYZING ELECTROMAGNETIC FIELD OF CIRCUIT BOARD, AND CIRCUIT BOARD AND METHOD FOR DESIGNING

THE SAME

[Corresponding to PCT/JP2004/011242 Filed August 5, 2004]

THE COMMISSIONER IS AUTHORIZED TO CHARGE ANY DEFICIENCY IN THE FEES FOR THIS PAPER TO DEPOSIT ACCOUNT NO. 23-0975

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

1a.

Pursuant to the provisions of 37 CFR 1.56, 1.97 and 1.98, Applicants request consideration of the references listed on attached form PTO-1449 and any additional information identified below in paragraph 3. A legible copy of each reference listed on the Form PTO-1449 is enclosed, except a copy is not provided for:

	each U.S. Patent and U.S. Patent application publication;
[]	each reference previously cited in the international application PCT/; and/or
[]	each reference previously cited in prior parent application Serial No.
IXI TI	nis Information Disclosure Statement is submitted:

within three months of the filing date (or of entry into the National Stage) of the above-entitled application, or

before the mailing of a first Office Action on the merits or the mailing of a first Office Action after the filing of an RCE,

and thus no certification and/or fee is required.

1b. [] This Information Disclosure Statement is submitted

after the events of above paragraph 1a and prior to the mailing date of a final Office Action or a Notice of Allowance or an action which otherwise closes prosecution in the application, and thus:

- (1) [] the certification of paragraph 2 below is provided, or
- (2) [] the fee of \$180.00 specified in 37 CFR 1.17(p) is enclosed.
- 1c. [] This Information Disclosure Statement is submitted:

after the mailing date of a final Office Action or Notice of Allowance or action which otherwise closes prosecution in the application, and prior to payment of the issue fee, and thus:

the certification of paragraph 2 below is provided, and

the fee of \$180.00 specified in 37 CFR 1.17(p) is enclosed.

- 2. It is hereby certified
 - a. [] that each item of information contained in this Information Disclosure

 Statement was first cited in any communication from a foreign patent office in a

 counterpart foreign application not more than three months prior to the filing of
 the Statement, or
 - b. [] that no item of information contained in the Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application and, to the knowledge of the person signing the certification

after making reasonable inquiry, was known to any individual designated in §1.56(c) more than three months prior to the filing of the Statement.

- 3. [] Consideration of the following list of additional information (including any copending or abandoned U.S. application, prior uses and/or sales, etc.) is requested.
- 4. For each non-English language reference listed on the attached form PTO-1449, reference is made to:
 - a. [] a full or partial English language translation submitted herewith,
 - b. [] a foreign patent office search report (in the English language) submitted herewith,
 - c. [] the concise explanation contained in the specification of the present application at page,
 - d. [] the concise explanation set forth in the attached English language abstract,
 - e. [] the concise explanation set forth below or on a separate sheet attached to the reference:
- 5. [X] A foreign patent office search report citing one or more of the references is enclosed.

Respectfully submitted,

Kazuhide URIU et al.

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JRF/fs

Washington, D.C. 20006-1021 Telephone (202) 721-8200 Facsimile (202) 721-8250 March 14, 2006

Sheet 1 of 1		,	SURE STATEMENT							
FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE					ATTY DOCKET NO. SERIAL N 2005_1579A 10/552,					
PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S)				APPLICANT Kazuhide URIU et al. MAR 1 4 2006					86 / ∣	
(Use several sheets if necessary) Date Submitted to PTO: March 14, 2006				FILING DATE October 11, 2005						
U.S. PATENT DOCUMENTS										
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE		NAME (E CLASS SUBCLASS FILING DATE APPROPRIAT				
	AA									
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FOREIGN PATENT DOCUMENTS										
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OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)										
	AO	Kuldip C. Gupta, "Emerging Trends in Millimeter-Wave CAD", IEEE Transactions on Microwave Theory and Techniques, IEEE Service Center, Piscataway, NJ, US, Vol, 46, No. 6, June 1, 1998, pages 747-752								
	AP	Takayuki Watanabe et al., "Parallel-Distributed FDTD-Based Full-Wave Simulator for Large-Scale Printed Wiring Boards", Electrical Performance of Electronic Packaging, October 21-23, 2002, Piscataway, NJ, USA, IEEE, October 21, 2002, pages 287-290								
	AQ									
EXAMINER					DATE CONSIDERED					

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copthis form with next communication to applicant.